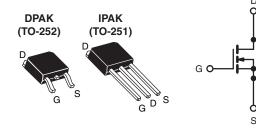


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	250			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.1		
Q _g (Max.) (nC)	14			
Q _{gs} (nC)	2.7			
Q _{gd} (nC)	7.8			
Configuration	Single			



N-Channel MOSFET

FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR224, SiHFR224)
- Straight Lead (IRFU224, SiHFU224)
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs form Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave solderig techniques. The straight lead version (IRFU, SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

ORDERING INFORMATION					
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)	
Lead (Pb)-free and Halogen-free	SiHFR224-GE3	SiHFR224TR-GE3	SiHFR224TRL-GE3	SiHFU224-GE3	
Lead (Pb)-free	IRFR224PbF	IRFR224TRPbFa	IRFR224TRLPbF ^a	IRFU224PbF	
	SiHFR224-E3	SiHFR224T-E3a	SiHFR224TL-E3 ^a	SiHFU224-E3	
SnPb	IRFR224	IRFR224TR ^a	IRFR224TRL ^a	IRFU224	
	SiHFR224	SiHFR224T ^a	SiHFR224TL ^a	SiHFU224	

Note

a. See device orientation.

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	250	- V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	_C = 25 °C _C = 100 °C	I.	3.8	А	
	VGS AL TO V	_C = 100 °C	ID	2.4		
Pulsed Drain Currenta			I _{DM}	15		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.020	VV/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	130	mJ	
Repetitive Avalanche Current ^a			I _{AR}	3.8	Α	
Repetitive Avalanche Energy ^a			E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C = 25 °C		D	42	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C		P _D	2.5	v	
Peak Diode Recovery dV/dt ^c			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg} - 55 to + 150		°C	
Soldering Recommendations (Peak Temperature)	for 10 s		-	260 ^d	7	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$; starting $T_J = 25 \text{ °C}$, L = 14 mH, $R_g = 25 \Omega$, $I_{AS} = 3.8 \text{ A}$ (see fig. 12).

c. $I_{SD} \leq 3.8$ A, dI/dt ≤ 90 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 150$ °C.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply

HALOGEN

FREE

Available

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	50		
Maximum Junction-to-Ambient	R _{thJA}	-	110	°C/W	
Maximum Junction-to-Case	R _{thJC}	-	3.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	$V_{GS} = 0 V, I_D = 250 \mu A$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.36	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$	-	-	± 100	nA
		$V_{DS} = 250 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	
zero Gate voltage Drain Current	ro Gate Voltage Drain Current I_{DSS} $V_{DS} = 200 V, V_{GS} = 0 V, T_J = 125 °C$		-	-	250	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 2.3 A ^b	-	-	1.1	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 2.3 A ^b	1.5	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5°		-	260	-	pF
Output Capacitance	C _{oss}			-	77	-	
Reverse Transfer Capacitance	C _{rss}			-	15	-	
Total Gate Charge	Qg		I _D = 4.4 A, V _{DS} = 200 V, see fig. 6 and 13 ^{b, c}	-	-	14	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	2.7	
Gate-Drain Charge	Q _{gd}			-	-	7.8	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 125 V, I _D = 4.4 A, R _G = 18 Ω, R _D = 28 Ω, see fig. 10 ^{b, c}		-	7.0	-	- ns
Rise Time	t _r			-	13	-	
Turn-Off Delay Time	t _{d(off)}			-	20	-	
Fall Time	t _f			-	12	-	
Internal Drain Inductance	L _D	6 mm (0.25")	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	nH
Internal Source Inductance	L _S				7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	3.8	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	15	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 \ ^{\circ}C, \ I_S = 3.8 \ A, \ V_{GS} = 0 \ V^b$		-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 4.4 A, dl/dt = 100 A/μs ^b		-	200	400	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.93	1.9	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	-on is dor	ninated b	$v L_s$ and	L _D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

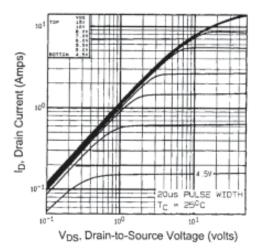


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

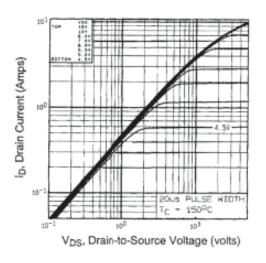


Fig. 2 - Typical Output Characteristics, $T_C = 150 \ ^{\circ}C$

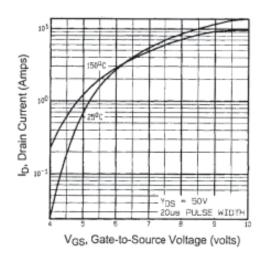


Fig. 3 - Typical Transfer Characteristics

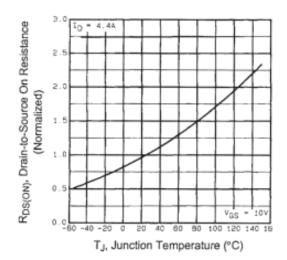


Fig. 4 - Normalized On-Resistance vs. Temperature

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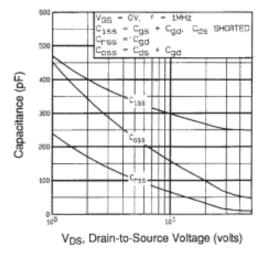
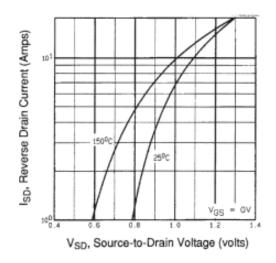


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





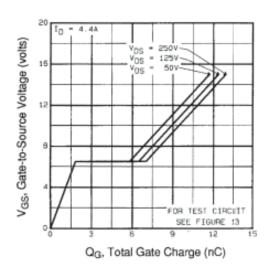


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

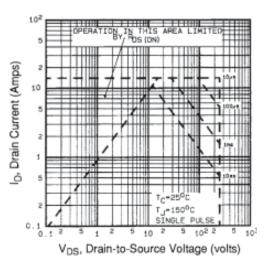


Fig. 8 - Maximum Safe Operating Area





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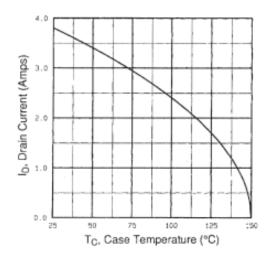


Fig. 9 - Maximum Drain Current vs. Case Temperature

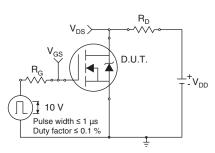


Fig. 10a - Switching Time Test Circuit

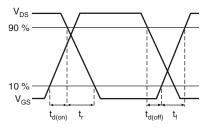


Fig. 10b - Switching Time Waveforms

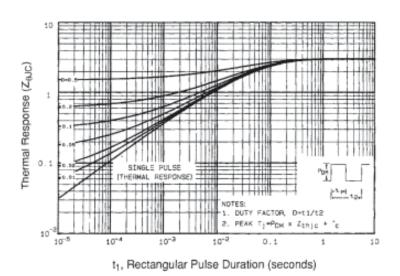


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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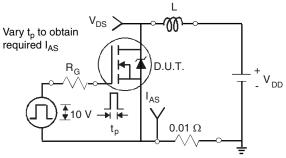


Fig. 12a - Unclamped Inductive Test Circuit

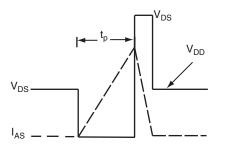


Fig. 12b - Unclamped Inductive Waveforms

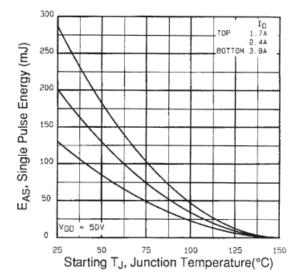


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

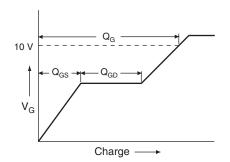


Fig. 13a - Basic Gate Charge Waveform

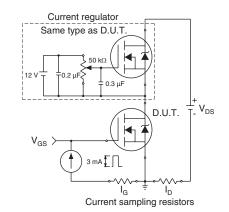
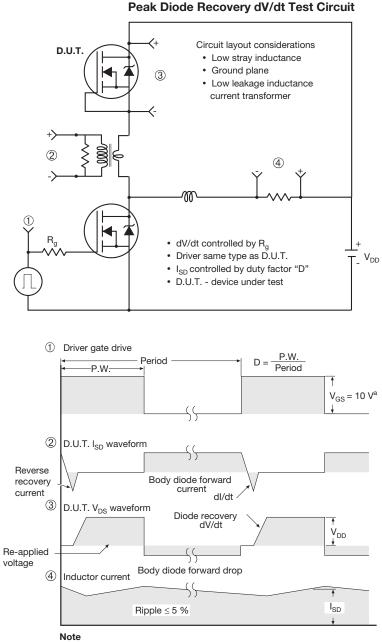


Fig. 13b - Gate Charge Test Circuit





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a. $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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Document Number: 91271 S10-1122-Rev. B, 10-May-10



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